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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,614	CHOI ET AL.	
Examiner	Art Unit	_
David Schindler	2862	

SEARCHED			
Class	Subclass	Date	Examiner
324	249	9/5/2005	DS
324	253	9/5/2005	DS
324	258	9/5/2005	DS
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
324/244,253,258,249,260.ccls. 438/3,48,14 (text search - see search history printouts - all databases)	9/4/2005	DS	
East - text search - see search history prinouts - all databases	9/4/2005	DS	